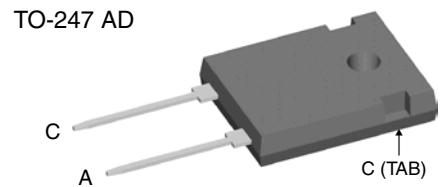
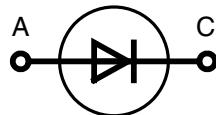


HiPerFRED™ Epitaxial Diode with soft recovery

I_{FAV} = 60 A
V_{RRM} = 400 V
t_{rr} = 30 ms

V _{RSM}	V _{RRM}	Type
V	V	
400	400	DSEP 60-04A



A = Anode, C = Cathode, TAB = Cathode

Symbol	Conditions	Maximum Ratings		
I _{FRMS}		70	A	
I _{FAVM}	T _C = 120°C; rectangular, d = 0.5	60	A	
I _{FSM}	T _{VJ} = 45°C; tp = 10 ms (50 Hz), sine	600	A	
E _{AS}	T _{VJ} = 25°C; non-repetitive I _{AS} = 3.5 A; L = 180 µH	1.6	mJ	
I _{AR}	V _A = 1.5·V _R typ.; f = 10 kHz; repetitive	0.4	A	
T _{VJ}		-55...+175	°C	
T _{VJM}		175	°C	
T _{stg}		-55...+150	°C	
P _{tot}	T _C = 25°C	230	W	
M _d	mounting torque	0.8...1.2	Nm	
Weight	typical	6	g	

Symbol	Conditions	Characteristic Values		
		(T _{VJ} = 25°C, unless otherwise specified)	typ.	max.
I _R ①	T _{VJ} = 25°C V _R = V _{RRM} T _{VJ} = 150°C V _R = V _{RRM}		650 2.5	µA mA
V _F ②	I _F = 60 A T _{VJ} = 150°C T _{VJ} = 25°C		1.14 1.50	V V
R _{thJC} R _{thCH}	V _{CE} = 0 V; V _{GE} = ± 20 V	0.25	0.65	K/W K/W
t _{rr}	I _F = 1 A; -di/dt = 300 A/µs; V _R = 30 V; T _{VJ} = 25°C	30		ns
I _{RM}	V _R = 100 V; I _F = 130 A; -di _F /dt = 100 A/µs T _{VJ} = 100°C	6.0	7.5	A

Pulse test: ① Pulse Width = 5 ms, Duty Cycle < 2.0%
 ② Pulse Width = 300 µs, Duty Cycle < 2.0%

Data according to IEC 60747 and per diode unless otherwise specified.

**Recommended replacement:
DPG60I400HA**

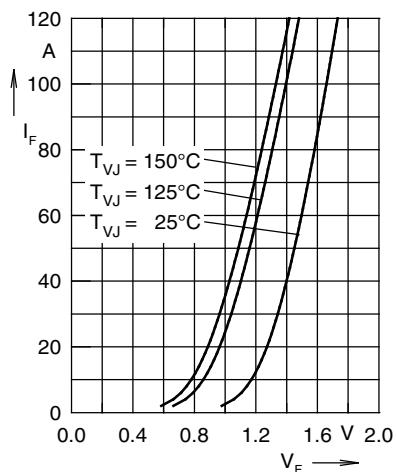
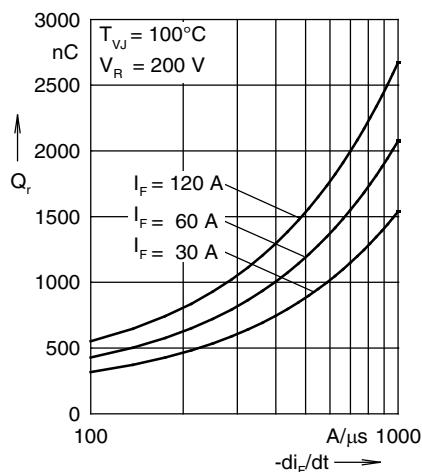
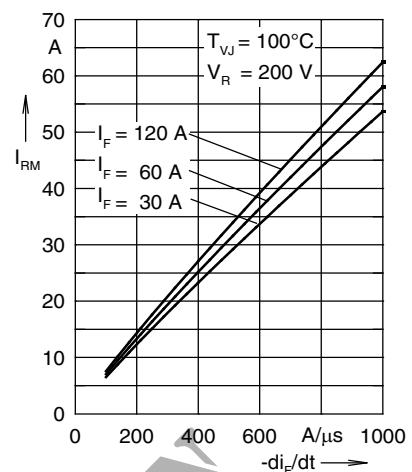
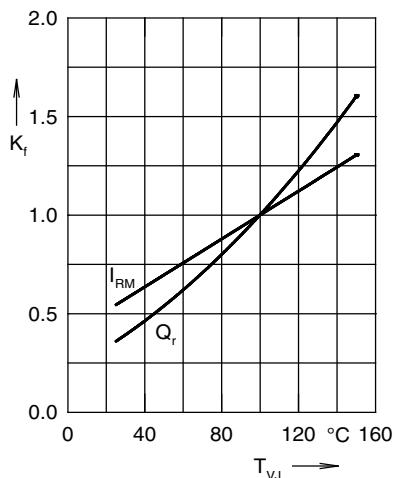
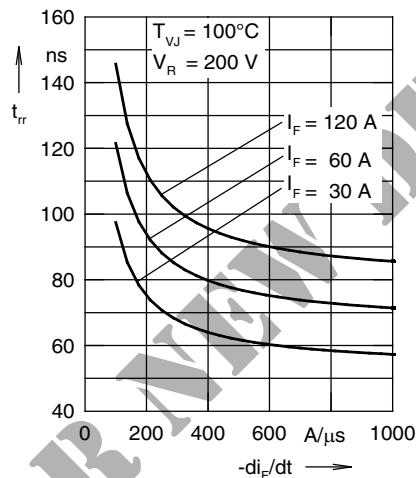
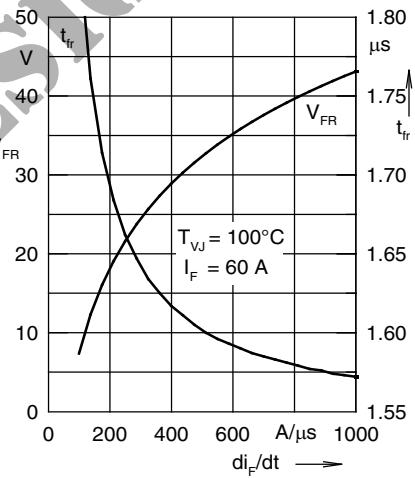
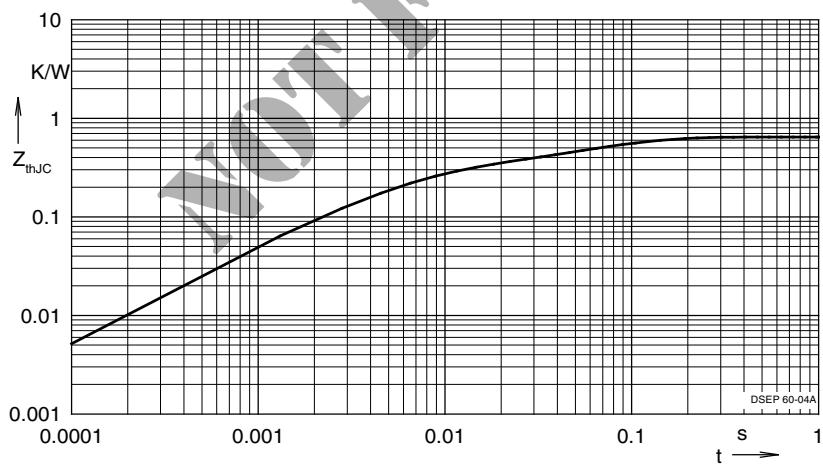
Fig. 1 Forward current I_F versus V_F Fig. 2 Typ. reverse recovery charge Q_r Fig. 3 Typ. peak reverse current I_{RM} Fig. 4 Typ. dynamic parameters Q_r , I_{RM} Fig. 5 Typ. recovery time t_{rr} vs. $-di_F/dt$ Fig. 6 Typ. peak forward voltage V_{FR} and t_{rr} 

Fig. 7 Transient thermal resistance junction to case

Constants for Z_{thJC} calculation:

i	R_{thi} (K/W)	t_i (s)
1	0.324	0.0052
2	0.125	0.0003
4	0.201	0.0385